

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/657,350	BOYKIN ET AL.	
Examiner	Art Unit	_
Sin J. Lee	1752	

	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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EAST TEXT Search (All search History printout)	2-5 -06	SJL		
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